

**Search Notes**

Application/Control No.

10/081,968

Examiner

Jacob Y. Choi

Applicant(s)/Patent under  
Reexamination

FUJINO ET AL.

Art Unit

2875

**SEARCHED**

| Class | Subclass                    | Date       | Examiner |
|-------|-----------------------------|------------|----------|
| 362   | 31, 331,<br>261, 339,<br>26 | 4/27/2005  | JC       |
| 385   | 49, 88                      | 4/27/2005  | JC       |
| 385   | 146                         | 4/27/2005  | JC       |
| ALL   | ALL                         | 11/4/2005  | JC       |
| ALL   | ALL                         | 11/13/2005 | JC       |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE      | EXMR |
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| Class/Subclass Search<br>362 - John Ward | 4/26/2005 | JC   |
| 385 - John Lee                           | 4/26/2005 | JC   |
| Text Search performed by the<br>examiner | 4/27/2005 | JC   |
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